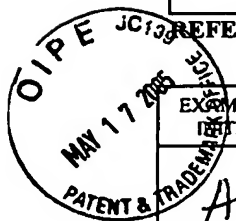


FORM PTO-1449	ATTY. DKT NO.	11-207	SER. NO.	10/716,795
	APPLICANT	Samukawa et al.		
	FILING DATE	November 20, 2003	GROUP	2636



REFERENCE DESIGNATION

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EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
AL	5,731,779 (English counterpart of JP A-H09-178856)	Mar. 24, 1998	Kikuchi	342	70
AL	6,597,307 (English counterpart of JP A-2002-257926)	Jul. 22, 2003	Nakanishi et al.	342	70
AL	6,061,001 (English counterpart of JP A-2000-56020)	May 9, 2000	Sugimoto	340	903
AL	2004/0065814 (English counterpart of JP A-2004-125739)	Apr. 8, 2004	Miyazaki et al.	256	222.1
AL	2002/0189875 (English counterpart of JP-A-2002-202360)	Dec. 19, 2002	Asanuma et al.	180	169

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TRANSLATION

	DOCUMENT NUMBER	DATE	COUNTRY	NAME	CLASS	SUB CLASS	YES	NO	
									Eng. Abstract
AL	JP-A-H09-178856 (Counterpart of US5,731,779)	7/11/97	Japan	Kikuchi	—	—		X	
AL	JP-A-2002-174684	6/21/02	Japan	Matsuda	—	—			X
AL	JP-2002-257926 (Counterpart of US6,597,307)	9/11/02	Japan	Moti	—	—		X	
AL	JP-A-2000-56020 (Counterpart of US6,061,001)	2/25/00	Japan	Yoshi	—	—		X	
AL	JP-A-2004-125739 (Counterpart of US 2004/0065814)	4/22/04	Japan	Hidemori	—	—		X	
AL	JP-A-2003-107159	4/9/03	Japan	Kikuchi	—	—			X
AL	JP-A-2002-202360	7/19/02	Japan	Asanuma	—	—		X	
AL	JP-A-2001-21646	1/26/01	Japan	Kishida	—	—			X

* Full English text of the JP Document will be available in machine-translated form from JP (Japanese Patent Office) English language web site at <http://www1.ipdl.jpo.go.jp/PA1/cgi-bin/PA1INDEX>.

OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
Anh La	6/17/05